# Sensitivity Analysis with the  $R^2$ -Calculus Tobias Freidling<sup>1,2</sup>, Qingyuan Zhao<sup>1,2</sup>

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## Untestable Assumptions



There is no unmeasured confounder  $U$ , i.e.  $U$  cannot effect  $D$  and  $Y$  (yellow arrows) simultaneously.

The instrument  $Z$  influences  $Y$ only through  $D$  and it is independent of  $U$ , that is absence of the red arrows.

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# $R^2$ -Calculus

In a linear regression  $Y = X \beta + \varepsilon$ ,  $R_{Y \sim X}^2$  is the proportion of variance in  $Y$  that is explained by the model.

Let  $Y \in \mathbb{R}, \, X \in \mathbb{R}^d, \, Z \in \mathbb{R}^k$  and  $W \in \mathbb{R}^l$  be random vectors

 $R_{Y\sim X}^2=1-\frac{\text{var}(Y-X\beta)}{\text{var}(Y)}$  $\frac{\Gamma(1-\Delta D)}{\text{var}(Y)}$ , where  $\beta$  is the regression coefficient  $R_{Y \sim X|Z}^2 = \frac{R_{Y \sim X+Z}^2 - R_{Y \sim Z}^2}{1 - R_{Y \sim Z}^2}$  $\frac{\text{var}(Y^{\perp X, Z})}{\cdot}$  $\frac{\mathrm{var}(Y^{\pm X, \omega})}{\mathrm{var}(Y^{\pm Z})} = 1 - R_{Y \sim X|Z}^2$  $\blacktriangleright \; R_{Y \sim X|Z} = \text{corr}(Y^{\perp Z}, X^{\perp Z}), \text{ for } X \in \mathbb{R}$  $R_{Y\sim X|Z,W}=\frac{R_{Y\sim X|Z}-R_{Y\sim W|Z}R_{X\sim W|Z}}{\sqrt{1-R_{Y\sim W|Z}^2}\sqrt{1-R_{X\sim W|Z}^2}}$ , for  $X, W \in \mathbb{R}$ .  $\blacktriangleright$   $f_{Y\sim X|Z}^2 = \frac{R_{Y\sim X|Z}^2}{1-R_{Y\sim X|Z}^2};$   $f_{Y\sim X|Z} = \frac{R_{Y\sim X|Z}}{\sqrt{1-R_{Y\sim X}^2}}$ , for  $X \in \mathbb{R}$ 

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#### R<sup>2</sup>-Calculus

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\n- $$
R_{Y \sim X}^2 = 1 - \frac{\text{var}(Y - X\beta)}{\text{var}(Y)}
$$
, where  $\beta$  is the regression coefficient
\n- $R_{Y \sim X|Z}^2 = \frac{R_{Y \sim X+Z}^2 - R_{Y \sim Z}^2}{1 - R_{Y \sim Z}^2}$
\n- $\frac{\text{var}(Y^{\perp X, Z})}{\text{var}(Y^{\perp Z})} = 1 - R_{Y \sim X|Z}^2$
\n- $R_{Y \sim X|Z} = \text{corr}(Y^{\perp Z}, X^{\perp Z})$ , for  $X \in \mathbb{R}$
\n- $R_{Y \sim X|Z,W} = \frac{R_{Y \sim X|Z} - R_{Y \sim W|Z}R_{X \sim W|Z}}{\sqrt{1 - R_{Y \sim W|Z}^2}\sqrt{1 - R_{X \sim W|Z}^2}}$ , for  $X, W \in \mathbb{R}$ .
\n- $f_{Y \sim X|Z}^2 = \frac{R_{Y \sim X|Z}^2}{1 - R_{Y \sim X|Z}^2}$ ;  $f_{Y \sim X|Z} = \frac{R_{Y \sim X|Z}^2}{\sqrt{1 - R_{Y \sim X|Z}^2}}$ , for  $X \in \mathbb{R}$
\n

### Sensitivity Analysis - Linear Regression

Linear regression model:

$$
Y = D\beta + U\gamma + \lambda^T X + \varepsilon
$$

Bias in the  $\beta$ -estimate when excluding U:

bias = 
$$
R_{Y \sim U|D,X} f_{D \sim U|X} \frac{\text{sd}(Y^{\perp D,X})}{\text{sd}(D^{\perp X})}
$$



We can find a range for the bias by reasoning about  $R_{Y \sim U(D,X)}$  and  $f_{D\sim U|X^+}$  For instance, if a researcher believes  $R^2_{D\sim U} \leq 0.5\,R^2_{D\sim X^+}$  we apply the rules of the  $R^2$ -calculus and find the bound

$$
|f_{D\sim U|X}| \le \sqrt{\frac{0.5f_{D\sim X}^2}{1 - 0.5f_{D\sim X}^2}}.
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Linear Instrumental Variables model:

$$
D = Z\theta + U\gamma + \lambda^T X + \varepsilon_D
$$
  
 
$$
Y = D\beta + U\tilde{\gamma} + \tilde{\lambda}^T X + Z\tilde{\theta} + \varepsilon_Y
$$

The estimate

$$
\beta_{\rm IV} = \frac{\text{cov}(Z, Y)}{\text{cov}(Z, D)}
$$



is unbiased if the instrument  $Z \in \mathbb{R}$  influences Y only through D and  $Z \perp\!\!\!\perp U$ , even in the presence of an unmeasured confounder.

### Sensitivity Analysis - Instrumental Variables

Bias under violation of the assumptions (dropping conditioning on  $X$ ):

bias = 
$$
\left[ \frac{R_{Y \sim U|D,Z} f_{U \sim Z}}{f_{D \sim Z} \sqrt{1 - R_{D \sim U|Z}^2}} + \frac{R_{Y \sim Z|D,U} \sqrt{1 - R_{Y \sim U|D}^2}}{R_{D \sim Z} \sqrt{1 - R_{Z \sim U|D}^2} \sqrt{1 - R_{Y \sim Z|D}^2}} \right] \frac{\text{sd}(Y^{\perp D,Z})}{\text{sd}(D^{\perp Z})}
$$

The values  $R_{U\sim Z}$  and  $R_{Y\sim Z|D,U}$  correspond to the IV assumptions. For sensitivity analysis, we need a bound on one additional parameter, for example  $R_{Y \sim U|D,Z}$ .

The unknown terms in the bias are implicitely specified by

$$
R_{Y \sim U|D,Z} = \frac{R_{Y \sim U|D} - R_{Y \sim Z|D} R_{Z \sim U|D}}{\sqrt{1 - R_{Y \sim Z|D}^2} \sqrt{1 - R_{Z \sim U|D}^2}}
$$

$$
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$$

$$
f_{Z \sim U|D} = f_{Z \sim U} \sqrt{\frac{1 - R_{D \sim Z}^2}{1 - R_{D \sim U|Z}^2}} - R_{Z \sim D} f_{D \sim U|Z}
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K-class estimate for a linear IV model:

$$
\beta_{\kappa} = \frac{\text{cov}(D^{\perp X}, Y^{\perp X}) - \kappa \text{cov}(D^{\perp Z, X}, Y^{\perp Z, X})}{\text{var}(D^{\perp X}) - \kappa \text{var}(D^{\perp Z, X})}
$$

Interpolation:

- $\triangleright$   $\kappa = 1$ : IV estimate
- $\triangleright$   $\kappa = 0$ : regression estimate of  $Y \sim D+X$



 $\triangleright$   $\kappa \rightarrow -\infty$ : regression estimate of  $Y \sim D+X+Z$ 

Bias under violation of IV and regression assumptions:

bias = 
$$
\left[\frac{f_{Y\sim Z|D,X} R_{D\sim Z|X}}{1 - \kappa (1 - R_{D\sim Z|X}^2)} + R_{Y\sim U|D,Z,X} f_{D\sim U|Z,X}\right] \frac{\text{sd}(Y^\perp)}{\text{sd}(D)}
$$

It suffices to specify bounds for two quantities:  $R_{Y \sim U(D,Z,X)}$  and  $f_{D\sim U|Z,X}$ . This extends to multiple independent instruments.

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## Outlook

#### Short-term:

- $\triangleright$  Multiple unmeasured confounders: An upper bound for the bias in linear regression is already known.
- $\triangleright$  "Combination" of the bounds for different sensitivity parameters: Do we want to allow simultaneous worst-case violations for multiple parameters?
- $\triangleright$  Application to real-world data, e.g. in econometrics

- Computer algebra system for the  $R^2$ -calculus
- Properties of  $R^2$ -calculus, e.g. what is the minimum number of sensitivity parameters for a given model?
- Generalisation of  $R^2$ -values

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#### Long-term:

- Computer algebra system for the  $R^2$ -calculus
- Properties of  $R^2$ -calculus, e.g. what is the minimum number of sensitivity parameters for a given model?
- Generalisation of  $R^2$ -values

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